

Search Notes

Application/Control No.

10/674,382

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

HIEDA ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	691	10/24/2005	BT
438	697	10/24/2005	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search inventors' name and keywords using EAST	10/24/2005	BT